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Opportunities and new developments for the study of surfaces and interfaces in soft condensed matter at the SIRIUS beamline of Synchrotron SOLEIL

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beamline, soft condensed matter, GIXD, GISAXS, GIWAXS, TXRF, surface science

Abstract

The SIRIUS beamline of the Synchrotron SOLEIL is dedicated to X-ray scattering and spectroscopy of surfaces and interfaces, covering the tender to mid-hard X-ray range (1.1-13 keV). The beamline has hosted a wide range of experiments in the field of soft interfaces and beyond, providing various grazing incidence techniques such as diffraction and wide angle scattering (GIXD/GIWAXS), small angle scattering (GISAXS) and X-ray fluorescence in total reflection (TXRF). SIRIUS also offers specific sample environments tailored for *in situ* complementary experiments on solid and liquid surfaces. Recently, the beamline has added compound refractive lenses associated with a transfocator, allowing for the X-ray beam to be focused down to $10 \times 10 \ \mu m^2$ while maintaining a reasonable flux on the sample. This new feature opens up new possibilities for faster GIXD measurements at the liquid-air interface and for measurements on samples with narrow geometries.

1. Introduction

Synchrotron-based grazing incidence X-ray techniques are powerful tools for investigating the structure and dynamics of surfaces and interfaces in soft condensed matter (Daillant, 2009; Pershan & Schlossman, 2012; Hexemer & Müller-Buschbaum, 2015; Narayanan & Konovalov, 2020). The pioneering work of Kjaer et al. (Kjaer *et al.*, 1987) and Dutta et al. (Dutta *et al.*, 1987), which first introduced these techniques for the study of organic layers at the air/water interface using Grazing Incidence X-ray Diffraction (GIXD) in 1987, has paved the way for their further development and application in the study of interfaces in soft matter systems. The establishment of third-generation synchrotron sources has led to the emergence of a diverse and complementary family of techniques, enhancing our ability to investigate interfaces in soft matter systems using grazing incidence methods.

The grazing incidence geometry relies on total reflection of X-rays, which occurs when the incident wave angle is below a critical value and propagates from a medium with a higher refractive index to an interface with a medium of lower refractive index, such as at air-liquid or air-solid interfaces (Daillant & Gibaud, 2009). Using X-rays with energies of typically 10 keV, only a thin interfacial layer of a few nanometers in depth is illuminated, while the bulk condensed phase remains unexposed and does not obscure the signal resulting from the interaction of X-rays with the surface (Fontaine et al., 2004). The photons that interact with the thin interfacial layer can undergo several events, including elastic scattering, inelastic scattering, and absorption (Daillant & Gibaud, 2009). Elastic scattering results in either diffuse or diffraction patterns if the layer has a degree of organization, while absorption results in the re-emission of a lower energy photon, in the so-called process of fluorescence.

Several techniques have been developed to provide a comprehensive understanding of air-liquid and air-solid interfaces at different length scales, depending on the detection technique, angular range, collimation, variation of the incidence angle, and potentially with chemical sensitivity. At low in-plane angles between the detection direction and incident beam $(2\theta < 1^{\circ})$, Grazing-Incidence Small-Angle X-ray Scattering (GISAXS) has been successfully used to unravel the structure of highly organized thin films at the nanoscale, such as, for example, surfaces patterned by the controlled deposition of block copolymers (Aubrit et al., 2018; Yu et al., 2020; Demazy et al., 2023). Moreover, the low divergence and high flux offered by third-generation synchrotron sources have played a crucial role in the increasing popularity of GISAXS measurements at the liquid-air interface (Daillant, 2009). Thus, the self-assembly of various systems, such as semi-fluorinated alkanes (Fontaine *et al.*, 2005; Fontaine *et al.*, 2018), colloids (Li-Destri et al., 2019), and Metal-Organic Frameworks (MOFs) (Andrés et al., 2021) or Polyhedra (MOPs) (Tejedor et al., 2022) at the air-water interface has been investigated using synchrotron-based GISAXS. At wider detection angles $(2\theta > 1^{\circ})$, the geometry of Grazing Incidence Wide Angle X-ray Scattering (GIWAXS) is preferred on solid thin films with crystalline features of length scales below 10 nm (Rivnay et al., 2012). This technique has become increasingly popular to understand structure-function relationships in organic electronics (King et al., 2021; Galerne et al., 2021; Labiod et al., 2022; Talnack et al., 2022; Swaraj & Hemmerle, 2023) and perovskite thin films (Filonik et al., 2019; Steele et al., 2023). The small interception of the sample with the beam in the geometry used for GISAXS and GIWAXS allows for the preservation of angular and wave vector resolution, enabling rich structural information to be extracted from the measured scattering patterns in a single shot using an area detector and a beamstop. This approach provides several advantages, as it enables the capture of essential features such as crystalline order, grain size, and coherence length, among others. In most cases, the image can be acquired in a sufficiently short time (on the order of 1-10 minutes) to capture dynamic events in so-called *in situ* experiments, where the film or device is subjected to external stimuli such as exposure to a particular solvent, gas, or light, a change in relative humidity, or even during operation in the case of *operando* measurements.

Grazing Incidence X-ray Diffraction (GIXD) is generally preferred for Langmuir films, *i.e.* molecular layers located at liquid-air interfaces, with scans of the reciprocal space using a collimator in front of a linear detector or an area detector. Because of the significant interception of the beam with the liquid surface under grazing incidence conditions (on the order of $50 \times 1 \text{ mm}^2$), the previous GIWAXS geometry yields poor angular resolution on liquid surfaces, making it unsuitable for obtaining valuable measurements. GIXD provided a major breakthrough in the understanding of Langmuir films in the 1990s (Kaganer *et al.*, 1999) and has since been widely used to explore various systems, including the self-assembly of molecular rigid rods (Fontaine *et al.*, 2019), the effects of drugs and pollutants on biomimetic systems (Michel *et al.*, 2015; Pereira-Leite *et al.*, 2019; Lopes-de-Campos *et al.*, 2021; Wójcik *et al.*, 2022; Matyszewska *et al.*, 2023), luminescence in 2D molecular crystals (Biswas *et al.*, 2021), and the structure of graphene oxide films (Bonatout *et al.*, 2017).

The SIRIUS (Soft Interfaces and Resonant Investigation on Undulator Source) beamline at the Synchrotron SOLEIL was designed to provide grazing incidence scattering and spectroscopy techniques over a unique energy range of 1.1-13 keV covering the tender to mid-hard X-rays domains (Fontaine *et al.*, 2014; Ciatto *et al.*, 2016). Since 2013, the beamline has been opened to users belonging to various communities in the fields of physics, chemistry and biology, with scientific interest in diverse topics such as functional materials, cell biology, environmental protection, health, energy storage and production. In the present paper, we discuss the recent updates to the beamline that are particularly relevant for the study of soft condensed matter systems. We first recall the main elements of the beamline layout, including the new Compound Refractive Lenses (CRLs) focusing system. Next, we detail the new GIWAXS/GISAXS environment for studies on solid substrates, the different strategies available to catch diffraction signal from Langmuir films associated to UV Visible spectroscopy and the recent modifications to the various facilities setups and configurations available on the beamline that are of interest to the soft matter community. Finally, we present a custom electronic notebook fully integrated to the data collection strategy of the beamline.

2. Beamline overview

The main components of the beamline are shown in figure 1 with the corresponding positions listed in table 1. In the following, we describe only the Double-Crystal Monochromator (DCM), the optical elements, and the various end-stations that are relevant to the study of soft matter systems in the energy range of $\simeq 6-13$ keV with linear polarization. Readers interested in the use of tender X-rays (between 1.1 and 5 keV), variable polarization, the Multilayer Grating Monochromator (MGM) and the absorption spectroscopy capabilities of SIRIUS beamline and associated optical elements, or in the in-vacuum diffractometer end-station, are referred to previous published papers on the subject (Ciatto *et al.*, 2016; Ciatto *et al.*, 2019).

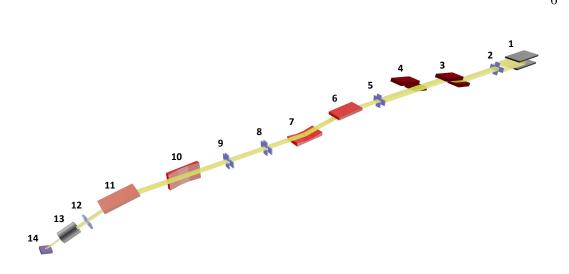


Fig. 1. Simplified layout of SIRIUS.

| Table 1. Positions | of the | components | displayed | in figure 1. |
|--------------------|--------|------------|-----------|--------------|
| | | | | |

| Index | Distance from source (m) | Component |
|-------|--------------------------|---|
| 1 | 0 | HU36 Undulator |
| 2 | 17.00 | Primary slits |
| 3 | 18.50 | Double-Crystal Monochromator |
| 4 | 20.00 | Multilayer Grating Monochromator |
| 5 | 21.10 | Secondary source slits |
| 6 | 22.00 | Mirror M1 (harmonic rejection) |
| 7 | 26.00 | Mirror M2 (vertical focusing) |
| 8-9 | 27.50-30.00 | Optical slits |
| 10 | 31.20 | Mirror M3 (horizontal focusing) |
| 11 | 32.80 | Mirror M4 (deflection) |
| 12 | 33.70 | Anti-scattering slits |
| 13 | 34.50 | Compound Refractive Lenses |
| 14 | 35.00 | 7-circle diffractometer |
| - | 0.28-4.50 | Position of area detector |
| | | (relative to a sample on the 7-circle diffractometer) |

2.1. Undulator

SIRIUS operates an helicoidal Apple-II undulator placed on a straight section, with a magnetic period of 36 mm (HU36) that provides X-rays covering a continuous energy range of at least 1–13 keV with variable polarization (linear horizontal, vertical or circular). This wide energy range is quite rare for an undulator source and required challenging optimization of the magnetic field and electron beam feedback corrections IUCr macros version 2.1.10: 2016/01/28 (Briquez *et al.*, 2008; Kitegi *et al.*, 2010). The undulator delivers a beam with a size first fixed by a diaphragm of $2.2 \times 0.8 \text{ mm}^2$ opening at 11.7 m from the source, followed by a pair of water-cooled primary slits (H & V) at 17 m from the source to define the usable beam before the monochromators.

2.2. Double-Crystal Monochromator

The fixed-exit DCM (FMB-Oxford, UK) located at 18.5 m from the source produces a monochromatic beam in the energy range of 2-13 keV using a pair of liquid nitrogencooled silicon crystals [111]. Such a large energy range requires a wide set of accessible Bragg angles (from -3 to 85°), which is rare for a cryo-cooled DCM. It is indeed quite difficult to prevent tubes and cables from intercepting the white beam on an angular range of about 90° while maintaining optimal stability and repeatability of the motors against gravity at large Bragg angles. Prior to each experiment, the monochromator energy calibration is checked by X-ray Absorption Spectroscopy near the absorption edges of Nickel (K-edge, 8.333 keV) or Zinc (K-edge, 9.659 keV) foils, ensuring a resolution of less than 5 eV in the 6-13 keV energy range. The control-command system of the DCM was upgraded to a Delta Tau PowerPMAC controller (Engblom et al., 2019), which allows driving the DCM directly in energy and opens the possibility of continuously scanning over the beamline energy range. This feature also enables quick energy changes during an experiment, facilitating, for example, adaptation of the q-range in GISAXS or optimization of fluorescence emission after changing a sample.

2.3. Mirrors & slits

The beamline is equipped with a set of 4 silicon mirrors downstream of the monochromators (DCM and MGM). These mirrors have different tracks coated with materials selected to optimize reflectivity at the chosen energy. For energies above 6 keV, platinum-coated tracks are used systematically. Mirror M1 is located 22 m from the source and reflects the beam downwards by 12 mrad (6 mrad on the mirror), providing harmonic rejection. Mirror M2, located at 26 m, can focus the beam vertically using a mechanical bender and reflects it back to an horizontal direction. Mirror M3, located at 31.2 m from the source, can focus the beam horizontally with the help of mechanical benders as well. Finally, mirror M4, situated at 32.8 m from the source, can be used to deflect the beam downwards to impinge on horizontal samples such as liquid surfaces, with an incidence of up to 0.5° on the mirror (1° on the sample). Vertical and horizontal focusing on the sample is achieved by using M2 and M3 to focus the beam to a spot of 100 $\mu m \times 100 \mu m$. Smaller beam sizes can be reached using a pair of slits as secondary source in combination with M2 and M3, with a flux reduction proportional to the closure. Two pairs of collimation (optical) slits, located after the M1 and M2 mirrors, allow us to define the size of the parallel beam in the unfocused directions, and a final set of anti-scattering slits is located just before the sample. These last slits are of prime importance when performing GISAXS at very small angles, for cleaning the beam of the spurious scattering caused by the optical slits upstream. The natural divergence of the beam is of 50 μ rad in both vertical and horizontal directions, and can be lowered to 10-30 μ rad at the sample position with collimation using the aforementioned slits. With such tunable configurations of mirrors and slits, the beam size can already be controlled to vary from millimeters to tens of micrometers with controlled divergence. The beam size can be further improved using our CRLs system, which is described in detail hereafter.

2.4. Compound Refractive Lenses

While the use of the two focusing mirrors M2 and M3 in combination with a significant closure of the secondary slits results in a large loss of flux, beam sizes smaller than 50 μ m have been achieved and utilized on the beamline. This has enabled investigations into the structure of confined surfactant solutions in a SFAX (a Surface Force Apparatus combined with X-ray scattering, SAXS and WAXS), despite the low flux. The SFAX, optimized for being operated on SIRIUS, opens the route to establishing the relationships between force-distance-structure under controlled nanoconfinement and under stress (Kékicheff et al., 2018; Kékicheff, 2019). In one such experiment, a collimated beam with a cross-section of around 10 μ m was required to match the cross-sectional area of the two opposing immersed surfaces. Although the success in achieving sub-50 μ m beam sizes is remarkable, there is a clear need in our user community to maintain high flux while strongly focusing the beam. For instance, we are currently working to increase the level of integration of SFAX to the beamline, which will greatly benefit the combination of a small beam and a high flux. More generally, this would be beneficial to various studies of confinement effects in soft matter systems (e.q. nanometric polymer layers, correlations between confined ions, phase transition in colloidal systems, ionic liquids), of heterogeneous samples with complex geometries, and of microfluidic chips with small lateral dimensions.

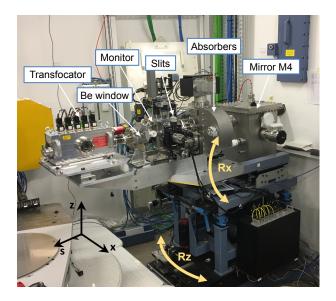


Fig. 2. Implantation of the transfocator on the beamline immediately before the diffractometer and sample stage, with the preceding upstream elements.

To focus the X-ray beam onto a small area while minimizing flux loss, we recently designed and acquired a transfocator capable of focusing the beam throughout a large range of energies and distances by inserting a variable number of Compound Refractive Lenses (CRLs) into the beam (Vaughan *et al.*, 2011). The transfocator is designed to work in combination with the M2-M3 mirrors for pre-focalization. To cover a wide energy range of 4 to 12 keV, we chose to use 24 beryllium lenses arranged in 5 packs, each on a motorized translation with excellent micrometric repeatability. The configuration of the lenses is described in table 2. The transfocator has been commissioned in 2022 and is now available for users. We describe here its main characteristics and performance in terms of focusing.

Table 2. Optimized configuration of the CRLs used with the SIRIUS transfocator, as a function of beam energy. N is the total number of CRLs inserted in the beam. T and f are

the transmissions and the focal lengths of the transfocator.

| | | | • | 0 | • | • | | |
|------------------|---------|---------|--------|--------|--------|----|-----|------|
| Energy | Pack 1 | Pack 2 | Pack 3 | Pack 4 | Pack 5 | N | T | f |
| (keV) | 2 CRLs | 4 CRLs | 6 CRLs | 6 CRLs | 6 CRLs | | | (m) |
| 4 | yes | no | no | no | no | 2 | 14% | 0.58 |
| 5 | no | yes | no | no | no | 4 | 14% | 0.46 |
| 6 | no | no | no | no | yes | 6 | 17% | 0.44 |
| 7 | yes | no | no | no | yes | 8 | 20% | 0.45 |
| 8 | no | yes | no | no | yes | 10 | 23% | 0.47 |
| 9 | no | no | yes | no | yes | 12 | 25% | 0.50 |
| 10 | yes | no | yes | yes | yes | 14 | 28% | 0.52 |
| 11 | no | yes | yes | yes | no | 16 | 30% | 0.55 |
| 12 | no | yes | yes | yes | yes | 22 | 26% | 0.48 |
| | | | | | | | | |

The lenses are identical and made of IS-50M beryllium with a radius of curvature at the apex of the parabola of $R = 50 \ \mu m$, a geometric aperture $2R_0 = 628 \ \mu m$, a length $L = 2 \ mm$ and a web thickness of $d = 30 \ \mu m$. The lenses were machined by RXOP-TICS GmbH (Germany), while the pack holder, translations, and transfocator vessel were purchased from Cinel Srl (Italy). Figure 2 depicts the system and its installation on the beamline. IS-50M beryllium has a relatively coarse grain microstructure, but it is suitable for focusing X-rays in the desired energy range. However, its polycrystalline structure may limit its future use with coherent beams when using the transfocator (Lyatun *et al.*, 2020). The transfocator is mounted on a motorized longitudinal translation (according to the beam) that can be adjusted to shift the focal point when inserting or removing packs. The entire assembly is further mounted on a table than can rotate around a vertical axis (Rz) centered on the M3 mirror rotation axis, and an horizontal axis (Rx) centered on the M4 mirror rotation (see Fig. 2). These two rotations enable all elements, including the transfocator, to accommodate the horizontal deviation of the M3 mirror and the vertical deflection of the M4 mirror.

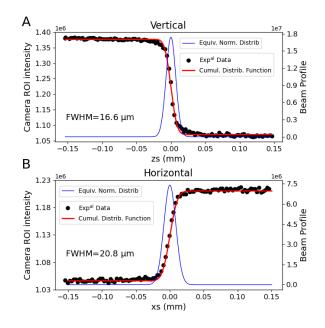


Fig. 3. Smallest beam size obtained with the transfocator without closing the secondary slit. Vertical (A) and horizontal (B) scans of a knife edge blade fitted by the cumulative distribution function of a normal law (red line) and the associated normal low used to extract the beam size (blue line).

To determine the size of the focused beam, we utilized a knife edge corner mounted on the 6-axis tower of the Newport diffractometer (see section 2.5). The knife edge was scanned vertically and horizontally using the motors of the diffractometer, at a fixed energy of 8 keV. The intensity profiles obtained were fitted with the cumulative distribution function of a Gaussian beam shape (González-Cardel *et al.*, 2013). Figure 3 shows the curves used to determine the smallest beam size obtained without resorting to the secondary slit as a secondary X-ray source, *i.e.* with an opening of 2×1.5 mm² (H × V) that corresponds to an almost full beam. After optimization of the transfocator alignment (Rx, Rz) and focalization, we obtained a beam size (Full Width at Half Maximum - FWHM) of $21 \ \mu m \times 17 \ \mu m$ (H × V). Note that the pre-focalization point by the M2 and M3 mirrors should be located within the transfocator to obtain the smallest sizes possible.

As a comparison, we measured the beam size without using the transfocator. First, $_{\rm IUCr\ macros\ version\ 2.1.10:\ 2016/01/28}$

we removed the lenses and kept the same pre-focalization with M2 and M3. In this case, the beam was considerably larger on the knife edge at the center of the diffractometer $(300 \times 150 \ \mu m^2)$. This is obviously expected since the focal point is located within the transfocator and not on the diffractometer center. After readjusting the focal point on the knife edge, still without the transfocator, we obtained a beam as small as $100 \times 100 \ \mu m^2$. To quantify the loss of intensity caused by the transfocator, we replaced the knife edge corner by an ion chamber (IC PLUS 50, FMB Oxford, England) filled with nitrogen at ≈ 1 atm, coupled to a current amplifier DDPCA-300 (FEMTO Messtechnik GmbH, Berlin, Germany) and connected to an ADC ADLink 2005 (ADLINK Technology Inc., Taiwan). Comparing the intensity with and without the transfocator inserted in the beam, we measured a transmission of 28 ±1% at 8 keV with 10 lenses inserted (packs 2 and 5).

We can compare our measurement of the transmission to the theoretical value derived analytically by Lengeler *et al.* for a stack of N CRLs (Lengeler *et al.*, 1999), using here only the dimensions of the lenses and the linear coefficient of attenuation μ :

$$T = \frac{R}{2\mu N R_0^2} e^{-\mu N d} \left(1 - e^{-2\mu N R_0^2/R} \right).$$
(1)

At an energy of 8 keV and for beryllium, we have $\mu = 2.077 \text{ cm}^{-1}$ (Henke *et al.*, 1993). Thus, we find that the calculated transmission for our CRLs stack is 23 %, which is close to our measured value. This agreement validates the efficiency of the chosen optical scheme, which includes a pre-focalization stage that allows the full flux to enter the transfocator through its aperture. Another interesting quantity that can be derived here is the focal length of the transfocator, which can be expressed as $f = R/(2N\delta)$, where δ is the real part of the complex X-ray refractive index. For our system, this gives us a focal length of f = 0.47 m at 8 keV. We provide

values of the transmissions and focal lengths computed with eq. 1 for the different energies in table 2. It is anticipated that the insertion of the CRLs may alter the divergence of the beam. Numerical simulations of the beamline conducted by SOLEIL's optics group have estimated a divergence of 100 μ rad in both vertical and horizontal directions. However, it is important to note that this estimate was obtained without considering the collimation of the incident beam with our optical slits. Therefore, the actual divergence of the focused beam should be measured on a case-by-case basis, but with an upper bound of 100 μ rad. These values still allow for measurements at grazing incidence (below 1 mrad) without the risk of X-rays exceeding the critical angle.

To conclude, keeping in mind our ultimate goal, we were able to achieve a beam size of $10 \times 10 \ \mu \text{m}^2$ by closing the secondary slits to $100 \times 100 \ \mu \text{m}^2$, with a proportional loss of intensity.

2.5. Diffractometer & 6-axis tower

The beamline is equipped with two diffractometers: a large 7-circle diffractometer manufactured by Micro-contrôle/Newport (Evry, France) located at a distance of 35 m from the source (Fontaine *et al.*, 2014; Ciatto *et al.*, 2016), and a second 4-circle invacuum diffractometer manufactured by Symetrie (Nîmes, France) located 39 m from the source (Ciatto *et al.*, 2019). The latter can be removed from the hutch and replaced with an optical table, as described in section 3.2. The sample stages associated with the in-vacuum diffractometer have been extensively described in previous works, and here we only recall the main features of the 6-axis tower stage on the large 7-circle diffractometer. This stage can accommodate different sample environments, including heavy ones up to 200 kg with an off-center mass. It allows for precise movement of the sample in six degrees of freedom, with a sphere of confusion of all rotations less than 60 μ m. The stage features a precise vertical translation of the sample with negligible backlash and 1 μ m repeatability, crucial for liquid surface alignment. In addition, two in-plane translations with a range of 50 mm are present, along with sample rotations provided by two crossed cradles limited to $\pm 10^{\circ}$, and a full rotation along the vertical axis. The resolution and repeatability of the motors for sample positioning are extremely accurate (Ciatto *et al.*, 2016), which is particularly useful for measurements in complex sample geometries (Kékicheff *et al.*, 2018; Galerne *et al.*, 2021).

The diffractometer is equipped with two detector arms. A first arm that can carry heavy detectors and collimation assemblies (up to 50 kg) and allows two rotations, in and out of the plane of the sample. A second arm consists of an optical table on which equipment weighing up to 200 kg can be positioned at distances ranging from 1.4 to 3.1 m from the sample, and which can rotate horizontally around the centre of the diffractometer on a marble track. A third static arm was added to the original setup to hold a third detector close to the sample for complementary measurements, usually an X-ray fluorescence detector, an optical camera, or a mobile microscope.

2.6. Detectors

The main features and uses of the detectors available on SIRIUS are described in table 3. Multiple monitors and X-ray Beam Position Monitors (XBPM) are placed between the main optical elements of the beamline and used for their alignment or for beamline monitoring. The XBPMs consist of 50 μ m for high energy and 3 μ m for tender energies thick diamond crystals forming a four quadrants diode (Desjardins *et al.*, 2014; Ciatto *et al.*, 2016). The beam position is given by the barycenter of the four currents returned by each diamond after amplification by LOCuM-4 amplifier (ENZ, Berlin, Germany), and the total intensity by their sum through a TANGO dedicated device. A complementary X-ray camera, developed by the SOLEIL detector group (Bordessoule, 2013), is used after the end-stations to align the beamline and the samples. It can withstand the full intensity of the direct X-ray beam while having a wide enough field of view to capture both direct and reflected beams from surfaces several meters away.

We will only list here the detectors available on the multipurpose diffractometer. Other detectors are available on the beamline but specialized for use in the in-vacuum diffractometer (Ciatto et al., 2019). A Pilatus 1M (Dectris, Switzerland) is used in most applications requiring a 2D detector and for GIXD in combination with a Soller collimator (see section 3.4). The 2D detector UFXC, result of a recent (ongoing) development by the SOLEIL detector group (Koziol et al., 2018; Dawiec et al., 2019), is used instead of the Pilatus3 1M for X-Ray Reflectivity (XRR), taking advantage of its smaller image and pixel size, and its higher dynamic range. When required, the intensity of the incident beam is measured for normalization by an IC PLUS 50 ion chamber as described in the section 2.4. Two silicon drift detectors (SDD) coupled to a four-channel xMAP Digital X-ray Processor (XIA, USA) are available to measure X-Ray Fluorescence (XRF) or X-Ray Absorption Spectroscopy (XAS). A first singleelement SDD XFlash 430M (Bruker, Germany) can be mounted on several of our sample environments due to its thin collimation tube and low weight. A second, larger, four-element SDD XFlash QUAD 5040 (Bruker, Germany) is used for low fluorescence signals requiring a larger sensitive area, of particular importance for measurements at solid-liquid interfaces (Malloggi et al., 2019).

Table 3. Main features and uses of the detectors available on the multipurpose 7-circles diffractometer.

| Detector | Characteristics | Use |
|------------------|--|--|
| Ion chamber | Filled with N_2 or Ar | Intensity normalization |
| X-ray camera | Spatial resolution: $35.5 \ \mu m$ | Beamline & sample alignment |
| | Detection area: 50 mm \times 40 mm | |
| Pilatus3 1M | 2D detector with hybrid-pixel technology | GISAXS, GIWAXS |
| | Pixel size: 172 $\mu m \times 172 \mu m$ | GIXD, off-specular reflectivity |
| | Number of pixels: 981×1043 | |
| | Linear response: up to $\sim 10^5$ photons/pixel/s | |
| UFXC | 2D detector with hybrid-pixel technology | XRR |
| | Pixel size: 75 $\mu m \times 75 \mu m$ | |
| | Number of pixels: 256×257 | |
| | Linear response: up to $\sim 10^6$ photons/pixel/s | |
| XFlash 430M | 1-element Silicon Drift Detector | XRF, TXRF, XAS |
| | Energy resolution: 133 eV | |
| | Sensitive surface: 30 mm^2 | |
| XFlash QUAD 5040 | 4-element Silicon Drift Detector | XRF (mostly solid-liquid interface), XAS |
| | Energy resolution: 135 eV | |
| | Sensitive surface: $4 \times 10 \text{ mm}^2$ | |

3. Sample environments & associated scientific examples

Here we describe sample environments available on the SIRIUS beamline that are of interest to the soft matter community, together with a selection of associated scientific examples.

3.1. In-helium chamber for GIWAXS & GISAXS on solid samples

Since its opening to users, SIRIUS has offered GIWAXS and GISAXS techniques for solid samples. Prior to 2021, two main sample environments were available depending on the desired temperature range, vacuum needs and compatibility, and potential exposure to solvent vapor: a "Baby" chamber with a beryllium dome and equipped with a high temperature oven (1000°C) (Ciatto *et al.*, 2016) or a chamber with Kapton windows on its facade (Fontaine *et al.*, 2014). However, both setups had a significant portion of the beam travelling in air from the beamline exit window to the chamber and then from the chamber to the detector. This, in addition to the numerous Kapton or beryllium windows traversed, led to a spurious background that had to be carefully accounted for in data analysis (Galerne *et al.*, 2021).

Following an increasing demand of GIWAXS *in situ* and *operando* measurements on samples with sometimes complex geometries and low diffraction signal, we have developed a custom environmental chamber, initially dedicated to GIWAXS experiments on solid samples. It allows helium to be flushed along the whole beam path with a direct connection to the detector and the beamline using gas-tight plastic bellows, and a single beryllium window upstream to preserve the beamline vacuum (see figure 4).

The new chamber configuration significantly improved the signal-to-noise ratio, making it easier to observe sample features immediately after acquisition and to subtract the background only later on.

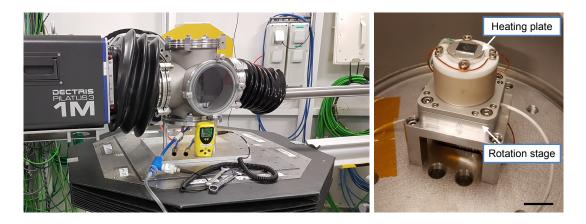


Fig. 4. Left: helium chamber in GIWAXS configuration. The chamber is directly connected to the beamline and the Pilatus detector via gas-tight bellows. A 200 μ m thick beryllium window in the inlet tube isolates the setup from the beamline vacuum. An oxygen sensor connected to an outlet of the chamber indicates the percentage of oxygen remaining in the chamber. Right: inside of the helium chamber with the rotation stage and the heating plate in place. The bar is 1 cm.

Figure 5 shows different GIWAXS patterns of thin films of ca. 45 nm thickness of a semiconducting polymer called PF_2 (Olla *et al.*, 2019) on bare silicon wafer, taken IUCr macros version 2.1.10: 2016/01/28 under various conditions at a beam energy of 10 keV. In figure 5-A, the raw images were taken without a tube between the beryllium exit-window of the beamline optics and between the sample and the detector, resulting in a few visible rings around 15 nm^{-1} and the clear need for challenging background subtraction, as in particular the low-q reflections expected in the 2-5 nm^{-1} range are hidden by the overlapping with the strong air scattering signal. In figure 5-B, the raw images were taken with the new setup but filled with air, which revealed more details, especially at low q values, due to most of the air scattering on the path between the upstream beryllium window and the sample being captured by the tube. Finally, in figure 5-C, the raw images were taken with the new setup filled with helium gas, which revealed many more features without background subtraction. The direct and reflected beam scattering by helium is much lower than with air, making acquisition much more efficient and data analysis easier, particularly when looking for weak diffraction spots and diffuse scattering (Heinrich *et al.*, 2023).

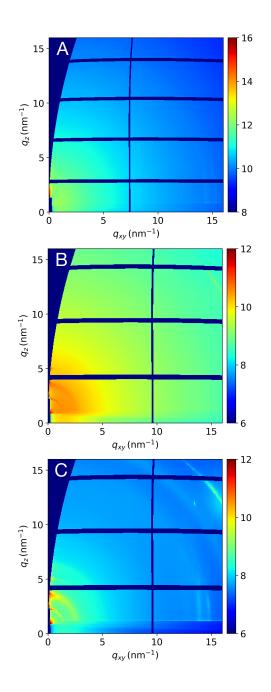


Fig. 5. GIWAXS images with a log intensity scale of a conjugated polymer thin film on bare silicon, taken with different conditions: A) without a tube between the exit-window and the detector, B) with the new GIWAXS setup but filled with air, and C) with the new GIWAXS setup filled with helium gas.

For GIWAXS measurements, we systematically use the Pilatus3 1M detector with a fixed sample-to-detector distance between 280 mm and 400 mm. Thus, the largest q range accessible in a single image without moving the detector is 0.5-30 nm⁻¹, using a beam energy of 12 keV. The diffraction pattern of silver behenate measured in transmission is typically used to calibrate the sample-to-detector distance and to convert the spatial and polar coordinates of the detector into scattering vectors (Nyam-Osor *et al.*, 2012).

The chamber offers a range of optional features, depending on the experimental requirements. An electrical resistor allows for heating the sample up to 250°C, and the control system can be programmed to implement complex heating patterns synchronized with the scans. Moreover, the sample can be mounted on an SR-4011 rotation stage (SmarAct GmbH, Germany), which provides an angular resolution of less than 2×10^{-6} degrees. A microscope (Dino-Lite, France) with magnification ranging from ×10 to ×140 can be mounted on top or on the side of the substrate, making it especially useful for samples with complex geometries or spatial heterogeneity. XRF measurements can also be taken by connecting one of the Silicon Drift Detectors to the side of the chamber with a bellow. Humidity can be controlled and measured within the chamber by flushing the helium in water before entering the vessel, ranging from dry to fully saturated conditions. Finally, when the sample needs to be exposed to hazardous gas or volatile solvents, a small inner chamber with 4.5 μ m thick aluminum windows can be placed inside the main chamber, on top of the rotation and heating stage.

This setup has been commissioned and opened to users in 2020 and is still evolving. For example, a sample changer is currently under development and is expected to be available in 2024. Several GIWAXS studies have already been conducted using this setup, including investigations into the structure change of phthalocyanine-based organic thin-film transistors (OTFTs) (Comeau *et al.*, 2022; King *et al.*, 2023), the self-assembly of poly(3-hexylthiophene) (Hicks *et al.*, 2022), and the structural characterization of titanium oxide nanowires for optoelectronics (Heinrich et al., 2023).

3.2. GISAXS capabilities on SIRIUS

Since opening to users, the capabilities of the beamline for GISAXS experiments have been enhanced for both solid surfaces and air/water interface studies. The sample environment described in section 3.1 was originally designed and optimized for GIWAXS experiments, but it can also be used in the GISAXS configuration, without any Kapton window connecting the chamber to the series of tubes that are filled with helium and placed between the detector (the Pilatus3 1M) and the sample. We are routinely using a series of beamstops consisting in 2.5 mm-wide stainless steel rods of different heights (30, 40 and 70 mm) with a rectangular cross-section and an engraved v-shape on the side that intercepts the usually 0.5 mm-wide X-ray beams (direct and reflected) and any related spurious scattering at low q values. The sample-to-detector distance can be varied between 1.3 m and 4.5 m by varying the dimensions of the tubes (see Fig. 6), allowing the minimum q value that can be reached to go down to 0.01 nm⁻¹ using 7 keV X-rays.

This setup has been used to study organic or mixed organic/inorganic layers on solid substrates, as for a recent example to investigate the registration fields for the formation of block copolymer structures using a layer-by-layer approach (Demazy *et al.*, 2023). On liquid surfaces, the maximum distance combined with the use of an 8 keV X-ray beam has enabled measurement of the organization of Metal Organic Frameworks (MOFs) spread as a monolayer at the air/water interface. The measurement revealed an hexagonal structure of the MOFs with the 01 and 11 peaks appearing at 0.0375 nm⁻¹ and 0.067 nm⁻¹, respectively, corresponding to a parameter of 232 nm (Andrés *et al.*, 2021).

3.3. Langmuir trough for coupling of in-situ measurements on films at the liquid/air interface

Experiments on Langmuir films, consisting of one or several layers of amphiphilic molecules at the interface between a liquid and a gas, comprise one third of the proposals performed on SIRIUS. These studies usually complement laboratory measurements at the sub-micrometer scale and are conducted on a dedicated Langmuir trough made of polytetrafluoroethylene (PTFE), which can be mounted on the multipurpose diffractometer (see figure 6). The trough has a total area of 700 $\rm cm^2$ and holds a typical subphase volume between 400 and 450 mL. The area per molecule is controlled with a single motorized PTFE barrier with a total compression ratio of 3.8. The surface tension of the liquid-air interface is measured by a Wilhelmy paper plate connected to a Riegler and Kirstein GmbH (Germany) sensor with an accuracy of 0.1 $mN.m^{-1}$. The area is controlled by an analogue electronic from the same provider, which also enables feedback on the surface pressure. The pressure feedback setpoint can be adjusted locally on the electronics or remotely from the TANGO control system, allowing scripting of layer compression and X-ray scans. Temperature control is achieved by circulating water inside the PTFE trough support, which is connected to an external water bath. This allows for precise temperature regulation within the trough, with the temperature range adjusted so far between 5°C and 45°C. Data acquisition and storage are performed through the TANGO control system of the beamline, either independently or together with X-ray data measurements.

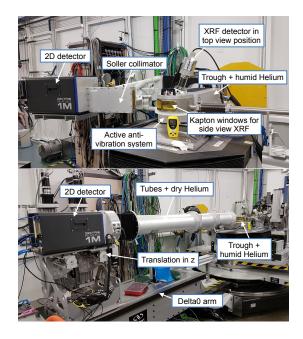


Fig. 6. Top: Langmuir trough for experiments at the liquid-air interface mounted on the 6-axis tower of the multipurpose diffractometer, enabling combined GIXD and XRF measurements. Bottom: sample deposited on the Langmuir trough with GISAXS tubes in place.

The trough is enclosed in a gas-tight box, flushed with helium that is saturated with water vapour to avoid evaporation of the sub-phase. The helium atmosphere is not only necessary to reduce background scattering at typical working energies of 6-10 keV, but is also of crucial importance to reduce beam damage to organic layers. The trough is directly connected to the beamline tube by means of a beryllium window located 800 mm upstream, far enough to avoid wide-angle scattering of the window from reaching the sample or the detector.

This setup has been used in several configurations, such as GIXD, GISAXS, Xray fluorescence in total reflection (TXRF), and off-specular scattering measurements (sometimes referred as GIXOS). GIXD is preferably performed with the Pilatus3 1M detector with a Soller collimator to fix and improve the angular resolution (see section 3.4). Two sets of Soller collimators are available, one with a resolution of 0.025° FWHM when high resolution is required (El Haitami et al., 2018; Fontaine et al., 2019), and another of 0.07° FWHM for wider diffraction peaks. These resolutions may slighly change depending on the sample to slit distance. TXRF can be measured in parallel with diffraction by placing the single-element SDD above the deposited laver, at a 30° angle with respect to the surface (backscattering geometry) to minimize the contribution of the elastic scattering. The four-element SDD can be used instead, but on a separate arm on the side of the trough. The information provided by X-ray fluorescence in complement of diffraction can be very valuable, in particular to probe the kinetics of absorption/desorption of chemical species at the interface (Andrés et al., 2021). GIXOS is a very promising and powerful tool for probing both the inplane and out-of-plane structure of a thin film at the air-water interface. Typically, the incident beam is maintained below the critical angle of total reflection of the interface, and a 2D detector equipped with one or two guard slits captures the scattered signal at an azimuthal angle of the order 0.2° to 1° (Dai *et al.*, 2011). As in X-ray reflectivity, GIXOS curves exhibit a pronounced dependence on the electron density profile of the interface, offering very valuable insights into the vertical structure of the sample (Mora et al., 2004; Dai et al., 2011). Moreover, it provides the potential to monitor dynamic processes in time-resolved experiments (Dai et al., 2013). Initial experiments utilizing GIXOS were recently conducted on the beamline. However, a significant challenge arose in the precise analysis of the experimental data. This complexity comes from the intrinsic dependence of GIXOS data on the fluctuation spectrum of the interface (Sinha et al., 1988; Mora et al., 2004) and the details of the experimental geometry (Dai et al., 2011). Even the basic task of accessing the electron density profile necessitates meticulous modeling of the GIXOS intensity, rendering it more intricate to employ compared to X-ray reflectivity, and is the subject of current work of the beamline staff to render it more accessible to the user community. Finally, the Langmuir trough can be included in the GISAXS setup (see section 3.2 and figure 6).

Complementary in situ measurements conducted in parallel with the X-ray acquisitions can greatly enhance the understanding of systems studied at the liquid-air interface, as the samples cannot be further characterized with laboratory equipment before or after the beam time. We therefore equipped the trough with a UV-visible spectrometer, in a transmission geometry (see figure 7-Top and Middle). The setup comprises a bifurcated optical fibre (Thorlabs SAS France, RP20 Reflection Probe, High-OH, SMA Connectors) and an Al-Coated mirror (Thorlabs SAS France, SMA905 aluminum reflective collimator) mounted on a kinematic mount (Thorlabs SAS France, Solaris K1) that illuminates the film with a parallel beam of white light. The light source is a DH-2000-BAL from Ocean Insight (Germany-Netherlands) with a halogen and a deuterium lamps providing light between 210 and 1500 nm. The optical fibre is positioned on top of the layer, and the light passes through the interface twice after reflecting on a silicon wafer at the bottom of the trough. The reflected light is directed back into the fibre, which carries it towards a UV-Visible spectrometer. Generally, users may bring their own spectrometer if it is compatible with the setup (mainly SMA connectors), and a dedicated spectrometer is expected to be available on the beamline in 2023. The entire setup is mounted on a horizontally translating platform perpendicular to the beam, as shown in figure 7A and 7B. This allows the apparatus to track any displacement of the trough that may occur when changing the X-ray illuminated area using the diffractometer translation. It also ensures that the area observed by the spectrometer remains focused on the X-ray illuminated region. Additionally, the motorised platform facilitates the cleaning of the whole trough, as it allows the probe to be moved away to access all parts of the trough.

As an example of an ongoing study using the *in situ* UV-visible setup, figure 7C shows the absorbance spectra of a 10,12-pentacosadyionic acid (PCDA) tri-layer at

room temperature at the air-water interface under continuous UV irradiation, measured with a spectrometer AvaSpec ULS2048XL-USB2 (grating UA 200nm-1160nm, slit of 25 μ m, Avantes, Netherlands). There is currently a significant research effort focused on the development of biological and chemical sensors using diacetylene molecules (Reppy & Pindzola, 2007; Rego *et al.*, 2021). These compounds (R-C=C-C=C-R', where R and R' are substituent groups) polymerize under UV irradiation in a topochemical manner, typically resulting in a blue polymer that transitions to a red form under different stimuli such as changes in pH or temperature, as well as during the irradiation. To be suitable for practical applications, polymerization must be stopped before the red form appears. However, the mechanism underlying the blue-to-red transition is not yet fully understood. The objective in this study is to investigate the link between color and structure by simultaneously measuring the diffraction and UV-visible spectra.

Finally, the microscope described in section 3.1 can be set in place of the spectrometer, above the liquid surface, to record the morphological transformations of a layer, such as the formation of large domains or a change of colour and opacity, for example in the case of large crystals formation or X-ray radiolysis.

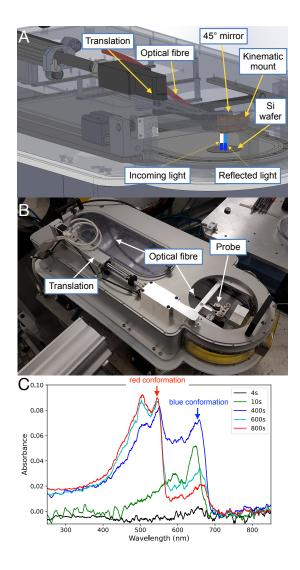


Fig. 7. In situ UV-visible spectroscopy integrated to the Langmuir trough. A) Schematic diagram, showing the double absorption of the light by the layer after reflection on a Si wafer. B) Annotated picture of the setup. C) Absorbance spectra of a PCDA Langmuir film under continuous UV irradiation as measured with the setup shown in A) and B).

3.4. Classic, single slit & slit-less GIXD

As described in the section 3.3, GIXD at the liquid-air interface is typically measured using the Pilatus3 1M detector with a Soller collimator oriented vertically in front of it (see figure 6). The Pilatus detector is used, in fact, as a 1D detector by integrating 2D images along the horizontal axis at each angle of the diffraction scan. IUCr macros version 2.1.10: 2016/01/28 The full diffraction spectrum is obtained by continuously scanning along the 2θ angle in the interface plane and at different discrete values of the out-of-plane angle for the detector. Continuous scanning is preferred to avoid sample perturbation induced by vibrations in step-by-step mode, in particular when probing liquid surfaces. This procedure also presents the advantage of reducing the dead times induced by the sleep times following each movement in a step-by-step scan. In such a continuous scan, the motor is slowly moved between the two extreme positions of the scanning angular range as the data are recorded on-the-fly. The speed of the motor is determined by the ratio of the angular range and the product of the number of points and counting time, with a correction factor applied to account for acquisition dead times. A custom Jupyter notebook is used to reduce the data and assemble scans at different values of the out-of-plane angle (see section 4). This process yields an intensity map $I(q_{xy}, q_z)$, where q_{xy} denotes the in-plane component of the scattering vector and q_z its vertical component. The result of such procedure is given in figures 8-A and 10-A.

At a given value of the out-of-plane angle, the time required for a scan between 12 and 16 nm⁻¹, which is the typical range for amphiphilic molecules in a monolayer, is about 15 minutes. For some systems, the scanning time can be reduced to a few minutes by reducing the sampling of q_{xy} and counting times. However, fast kinetic measurements with a characteristic time scale of less than a minute cannot be performed with this configuration. Nevertheless, some studies require much faster acquisition times, such as the study of the early stages of X-ray surface radiolysis process (Mukherjee *et al.*, 2015), as well as when beam damage occurs quickly, such as Langmuir films on divalent salts aqueous solutions (El Haitami *et al.*, 2018). Even if measurements were successfully performed on SIRIUS beamline using this former strategy, acquisition times below one minute for a full spectrum measurement are necessary. Two different geometries could be implemented on the SIRIUS beamline to enable such quick GIXD acquisition. The first one is based on a concept that we previously introduced on the X-ray liquid surface diffraction beamline (difliq) at the LURE, the former French national synchrotron source in Orsay, France (Fontaine *et al.*, 2004). This setup uses a two-dimensional detector combined with a single vertical slit (horizontal gap) and enables the measurement of the diffraction pattern of a 2D powder monolayer with an equivalent in-plane resolution and a faster acquisition time than the usual setup. Additionally, the resolution versus flux and the q_{xy} -range can be easily adjusted through the choice of the sample-slit-detector distances. This geometry was first introduced by some of us (Fontaine *et al.*, 2004) and has since been successfully implemented on other facilities (Meron *et al.*, 2009; Banerjee *et al.*, 2015).

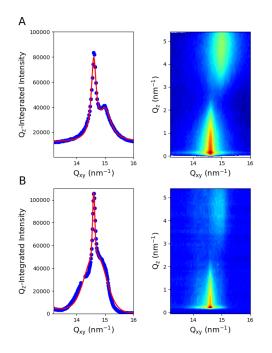


Fig. 8. GIXD spectra measured on a Langmuir monolayer of behenic acid compressed at 20 mN.m⁻¹ A) with the classical setup of a 2D detector with a Soller collimator, B) with the single vertical slit and 2D detector configuration (sample-to-detector distance: 770 mm, sample-to-slit distance: 240 mm, and slit horizontal gap 1 mm). Red lines are fits of the experimental data points by two Lorentz functions in A) and Gaussian functions in B), as discussed in text, and both with a linear sloping background. The two images do not have the same color scale due to different binnings in the number of points.

Figure 8-A shows a diffraction spectrum taken in 15 minutes with the scanning configuration using the Pilatus detector in combination with the Soller collimator of medium resolution (0.07°) on a behenic acid Langmuir monolayer compressed at 20 mN.m⁻¹ on pure water. It shows the classical two peaks pattern of the L2 phase of fatty acids Langmuir monolayers with the 11 peak maximum located out-of-the-plane and the 02 peak maximum located in plane as expected for Next Neighbour (NN) tilt of the molecules (Kenn *et al.*, 1991). In figure 8-B, the same pattern was measured using the GIXD geometry with the 2D detector at 770 mm from the sample and a single vertical slit located at 240 mm from the sample, 1.0 mm horizontal gap, with a counting time

of 5 minutes, and is shown here after subtraction of scattering by the surface of pure water. The two spectra showed the same diffraction pattern with one in-plane and one out-of-plane peak as expected, and only differ by the shape of the peaks. Even if the peak positions were roughly identical using the measured parameter values, a slight optimization of the angle of the detector arm with respect to the direct beam position is necessary using the known spectra of behenic acid at 20 mN.m^{-1} . This adjustment is primarily needed due to the limited resolution in aligning the detector arm with the direct beam, which typically falls within the range of a few tenths of a degree. As we have previously demonstrated, the resolution in the second geometry is controlled by the gap of the horizontal slit, and the sample-slit and sample-detector distances (Fontaine *et al.*, 2004). According to theoretical resolution calculation provided in the appendix of reference (Fontaine *et al.*, 2004), the q-resolution is around 0.075 nm^{-1} , which is nearly identical to one of the Soller collimator configuration. However, the resolution functions of the two configuration are not identical, which could explain the slight difference observed in the peak shapes. The experimental data points in the latter geometry are fitted using a Gaussian function, which can be rationalised given the different resolution functions of the two configurations. It is worth noting that the main characteristics of the diffraction pattern can already be observed in a few tens of seconds.

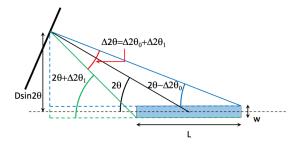


Fig. 9. Top view of the GIXD experiment without collimation system before the 2D detector with a footprint of size $(L \times w)$ and the different angles to determine the resolution of the measurement at a 2θ angle.

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Small beams are now more easily available on synchrotron beamlines, thanks to the possibility of focusing X-rays on few-micrometer spots. This trend will be reinforced in the near future with the advent of the so-called Diffraction Limited Storage Rings (DLSRs). Although at first sight such developments does not appear particularly interesting for the study of layers at the air/water interface, a new paradigm for the acquisition of the diffraction signal from a liquid surface with a symmetrical and smaller beam is conceivable. Indeed, if the beam size is sufficiently small, we can reach a footprint size for which the illuminated sample dimensions are negligible (at least small) with respect to the sample-to-detector distance. Thus, if we place a 2D detector at a distance D from the sample as in figure 9, we can simply express the horizontal angular resolution of one pixel as:

$$\Delta 2\theta = \arctan \frac{D \sin 2\theta - w/2}{D \cos 2\theta + L/2} - \arctan \frac{D \sin 2\theta + w/2}{D \cos 2\theta - L/2}$$
(2)

where 2θ is the in-plane detection angle, w is the width of the beam, $L = e/\sin\theta_{in}$ with e the vertical thickness of the beam, and θ_{in} the incidence angle.

For a 2D detector at D = 750 mm from the sample, a beam of $100 \times 100 \ \mu \text{m}^2$, which is the smallest size currently achievable at the SIRIUS beamline (without losing flux or using the transfocator), the angular resolution would be of 1.4° at $2\theta = 20^{\circ}$, almost two orders of magnitude larger than the best resolution achievable with the Soller collimator (see section 3.4). However, if we reduce the vertical beam size down to 20 μ m with the transfocator, the angular resolution becomes 0.26°, still above the resolutions of our two sets of Soller collimators but more reasonable for envisioning a GIXD measurement. We tested this simple geometry at 8 keV on a Langmuir film using the Pilatus3 1M detector at a distance of D = 750 mm from the center of the diffractometer and with a beam focused at $15 \times 24 \ \mu \text{m}^2$ (H × V) by the transfocator. IUCr macros version 2.1.10: 2016/01/28 Figure 10-B presents the result after 5 minutes of acquisition. Compared to the pattern in figure 10-A, the measured spectrum has similar features and peak positions to those obtained with the other two setups. It displays the characteristic features of the L2' phase of fatty acid monolayers, with two out-of-plane peaks at q_z -positions in a ratio of two, as expected for a Next Nearest Neighbour (NNN) tilt of the molecules (Kenn et al., 1991). However, in comparison to the spectra measured with the two previous geometries shown in figure 8, the overall quality is lower. The signal-to-noise ratio is smaller, approximately one, as opposed to 2.5 for the Soller collimator measurement. The high level of background noise can be attributed to the beam travelling through helium gas before the sample and through air after reflection. This results in spurious scattering that, in this geometry, is not blocked by any mask. For a future development of this geometry, it is imperative to establish a direct connection between the Langmuir trough and the detector, employing a design similar to the one described for GIWAXS in section 3.1. Besides, the peak widths are larger $(0.2 \text{ nm}^{-1} \text{ compared to } 0.1 \text{ nm}^{-1} \text{ for})$ the spectra measured with Soller collimator). Further reducing the beam size would enhance the resolution, e.g. at $1 \times 1 \ \mu m^2$, the resolution reaches 0.01°.

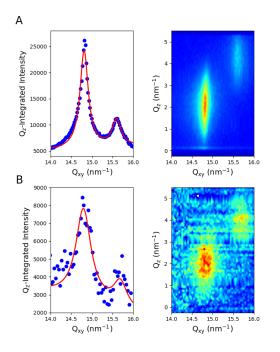


Fig. 10. GIXD spectra measured on a Langmuir monolayer of behenic acid compressed at 25 mN.m⁻¹ A) with the classical setup of a 2D detector with a Soller collimator, B) without any collimation system before the detector, but with a $15 \times 24 \ \mu\text{m}^2$ (H \times V) beam. The detector is located 750 mm from the centre of the sample. The red lines are fits by two Lorentz functions and a linear sloping background.

Nevertheless, this latest geometry using a small beam for GIXD raises some questions for future use besides the high density of photons that could induce sample degradation. While for conventional amphiphilic molecules such as fatty acids, alcohol, or lipids, the 2D powder distribution of the samples is usually satisfying when considering the beam size (and more precisely the footprint), new studies in the field of layers at the air/water interface have revealed inhomogeneities of similar or larger sizes than the beam's footprint. These features can typically be observed with Brewster angle microscopy, in systems such as behenic acid monolayers on cadmium salt solutions (Cantin *et al.*, 2004) and monolayers of DPPC and cholesterol mixture in contact with digitonin (Wojciechowski *et al.*, 2016), for example. Thus, when using this new approach for GIXD on such samples these inhomogeneities will have to be taken into account during analysis. Nevertheless, this geometry could offer a mean to address the structural determination of the domains. On forthcoming DLSR, where the beam is anticipated to be more coherent, the crystal sizes or structural correlation lengths may be of the same order of magnitude as the beam's coherence length. As such, this may therefore pose a challenge in future experimental measurements and analysis, but it could also provide novel opportunities.

In this context, the SIRIUS beamline gives access to a range of detection setups and beam shapes allowing to vary how the diffraction data collection at the air/water interface and tailor our approach to the needs of the systems and of the users. While the two first geometries described here, with a Soller collimator or a single slit, can be immediately used depending on their respective advantages, the third one can be seen as a prospective option, especially with the development of small beam capabilities on beamlines.

4. JupyLabBook: a customised electronic notebook

Since mid-2020, SIRIUS users have had access to a custom electronic notebook. This interactive notebook, called JupyLabBook, is based on a Jupyter Notebook core (https://jupyter.org/) enriched with several widgets (see figure 11). Designed as a *low-code* tool, users unfamiliar with programming can use it without writing a single line of code, after setting up of the notebook by the beamline staff, while an expert user can easily enrich it with Python code. The notebook allows users to quickly reduce and visualize data once a scan is complete, and to display the results in a clear and structured manner with headings and comments. Most of the experimental techniques present on the beamline can now be processed in the notebook, such as GIXD, GIWAXS, GISAXS, XRF, XRR and Langmuir isotherms. The alignment process and all the calibration parameters are reported at the beginning of the notebook file, and IUCr macros version 2.1.10: 2016/01/28 used for data reduction throughout the experiment.

JupyLabBook converts diffraction scans into reciprocal space, represented as a TIFF image and raw ASCII files, and fluorescence scans into individual energy-intensity spectra in the form of text files, and spectrograms as images. X-ray reflectivity data on solids can also be extracted as ASCII files using the notebook by integrating the 2D detector, performing proper background subtraction, and normalizing by the incident beam. The notebook is linked to the log files of SPyC, an IPython-based control and acquisition system developed at SOLEIL within TANGO framework, enabling automatic transfer of most of the information related to the scan. For users who prefer not to display graphs and figures for each scan, the notebook allows importing only the sequence of commands typed into SPyC, similar to what was previously recorded in paper notebooks. Once the experiment is complete, the notebook can be converted into a single PDF file that includes all the relevant information.

The open-source code of JupyLabBook is hosted on SOLEIL GitLab repository (https://gitlab.synchrotron-soleil.fr/sirius-beamline/notebooks/JupyLabBook) and version 3.0.2 is provided here in Supplementary Material. While it was specifically developed for the SIRIUS beamline, the code has been structured in a way that allows for potential adaptation to other beamlines, but without support of SIRIUS staff.

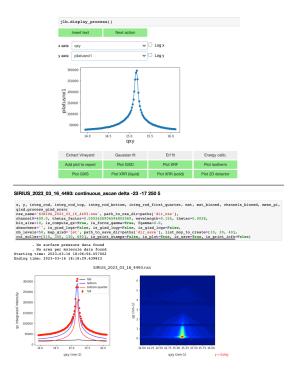


Fig. 11. Screenshots of JupyLabBook. After selecting the scan, the user can view the data included in the Nexus file and decide how the data should be processed. Top: quick visualization of a GIXD scan and widgets for selection of an appropriate data treatment. Bottom: notebook cell after full data extraction and conversion to q-space.

5. Conclusion

Since its opening to users in 2013, the SIRIUS beamline has hosted a wide range of experiments relevant to the soft condensed matter community. Researchers have investigated a variety of systems, including, among others, the behaviour of amphiphilic molecules, polymers, colloids and electrolytes, at liquid or solid interfaces. The results of these experiments are of potential interest to fields such as functional materials, energy storage, and biology. In this article, we have recalled the main characteristics of the SIRIUS beamline and presented a selection of recent developments that illustrates the growing need in the community for fast experiments with beams of tunable sizes, in combination with a number of *in situ* techniques. In this context, the IUCr macros version 2.1.10: 2016/01/28

SIRIUS beamline complements other similar facilities in terms of energy range and experimental techniques. These include I07 at Diamond (UK) (Nicklin et al., 2016), P03 at Petra III (Germany) (Buffet et al., 2012), ChemMat-Cars at APS (USA) (Lin et al., 2003), and ID10 at ESRF (France) (Smilgies et al., 2005; Jankowski et al., 2023), all of which we share many users with. In our future projects, we plan to improve our soft matter sample environment by integrating complementary characterization techniques alongside X-ray measurements. For example, we intend to incorporate a Brewster Angle microscope into our Langmuir trough, and investigate the application of small beams and X-ray beam coherence to soft matter systems using our transfocator. Furthermore, we aim to take advantage of the capabilities of the SIRIUS beamline for X-ray absorption spectroscopy and resonant or anomalous scattering techniques applied to soft interfaces, including the tender X-ray energies (1 to 4 keV). To achieve these goals, we could utilize the MGM monochromator and the windowless in-vacuum diffractometer for low energy resonant GISAXS and GIWAXS studies, as well as absorption spectroscopy at the sulfur K-edge (2473 eV), for example. This would constitute a significant advancement in the exploration of organic materials, particularly in multicomponent systems, as demonstrated by the work of Coric et al. on resonant GISAXS work on P3HT:PCBM (poly(3-hexylthiophene-2,5-diyl):phenyl-C61-butyric acid methyl ester) (Coric *et al.*, 2018).

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Synopsis

The main characteristics of the beamline SIRIUS at the Synchrotron SOLEIL relevant for soft matter science are presented, as well as recent developments of new sample environments and of X-ray focusing with compound refractive lenses.